

(Use several sheets if necessary)			Atty. Docket No. 19987		Application No. 10/584,738		
			Applicant Yoshikazu KAKURA				
			Filing Date June 26, 2006		Group Art Unit 2611		
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL*		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (if appropriate)
<b>U.S. PATENT PUBLICATION DOCUMENTS</b>							
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES
<b>OTHER (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
		Takuya KADOYA ET AL., "Studies on MMFSK System, Construction of hopping pattern, Parallel MMFSK System" Technical Report of IEICE, SST, Spread Spectrum, Japan, The Institute of Electronics, Information and Communications Engineers; October 13, 2000; Vol. 100, No. 362, pp. 25-30					
		Japanese Office Action dated October 27, 2010 with partial English translation					
EXAMINER			DATE CONSIDERED				
<p>* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>							